

## Supporting Information

Improving thermal- and photo-stability of CsPbBr<sub>3</sub> perovskite films by adding graphene oxide for low threshold amplified spontaneous emission

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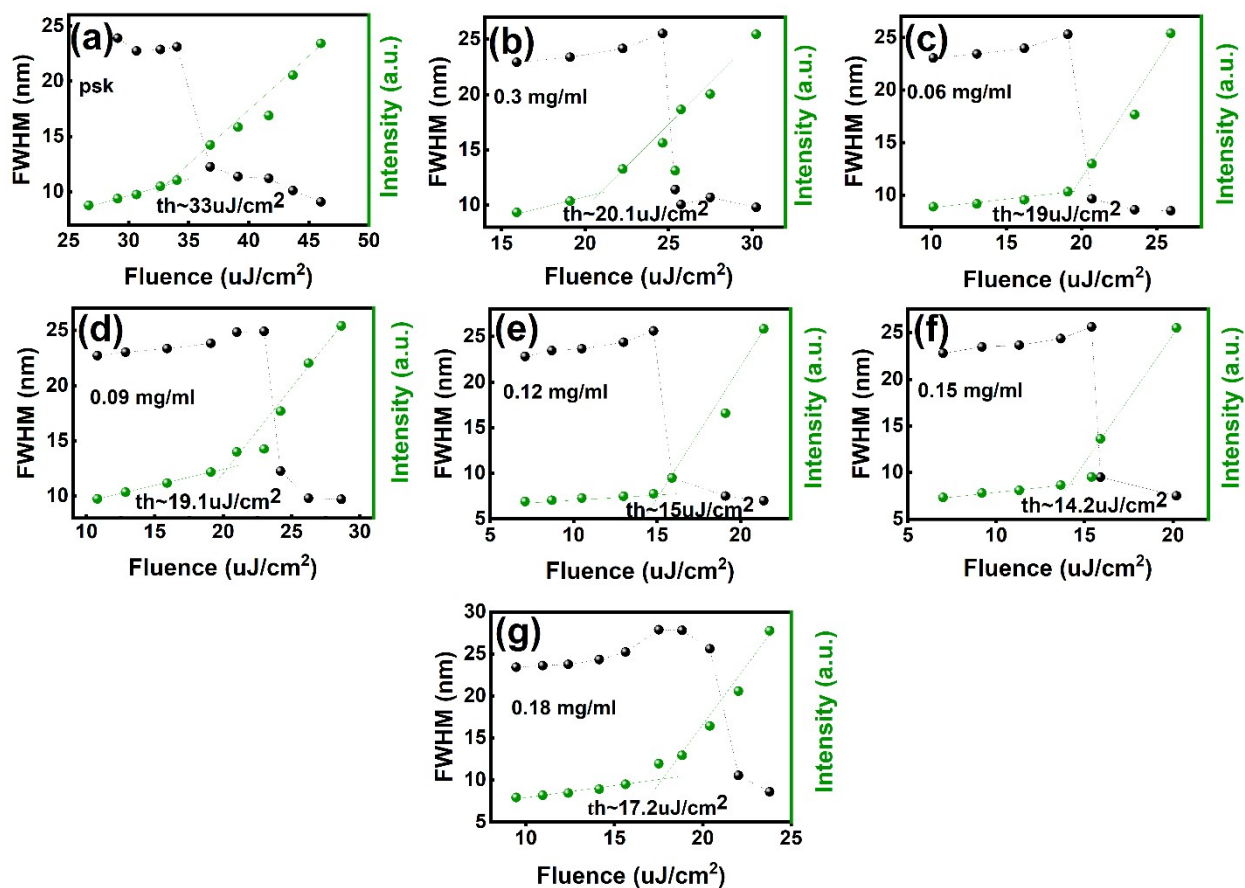


Fig S1. The FWHM and ASE intensity versus excitation fluence of the pure perovskite and different concentrations (0.03-0.18mg/ml GO) of CsPbBr<sub>3</sub>:GO thin films without annealing (a-g).

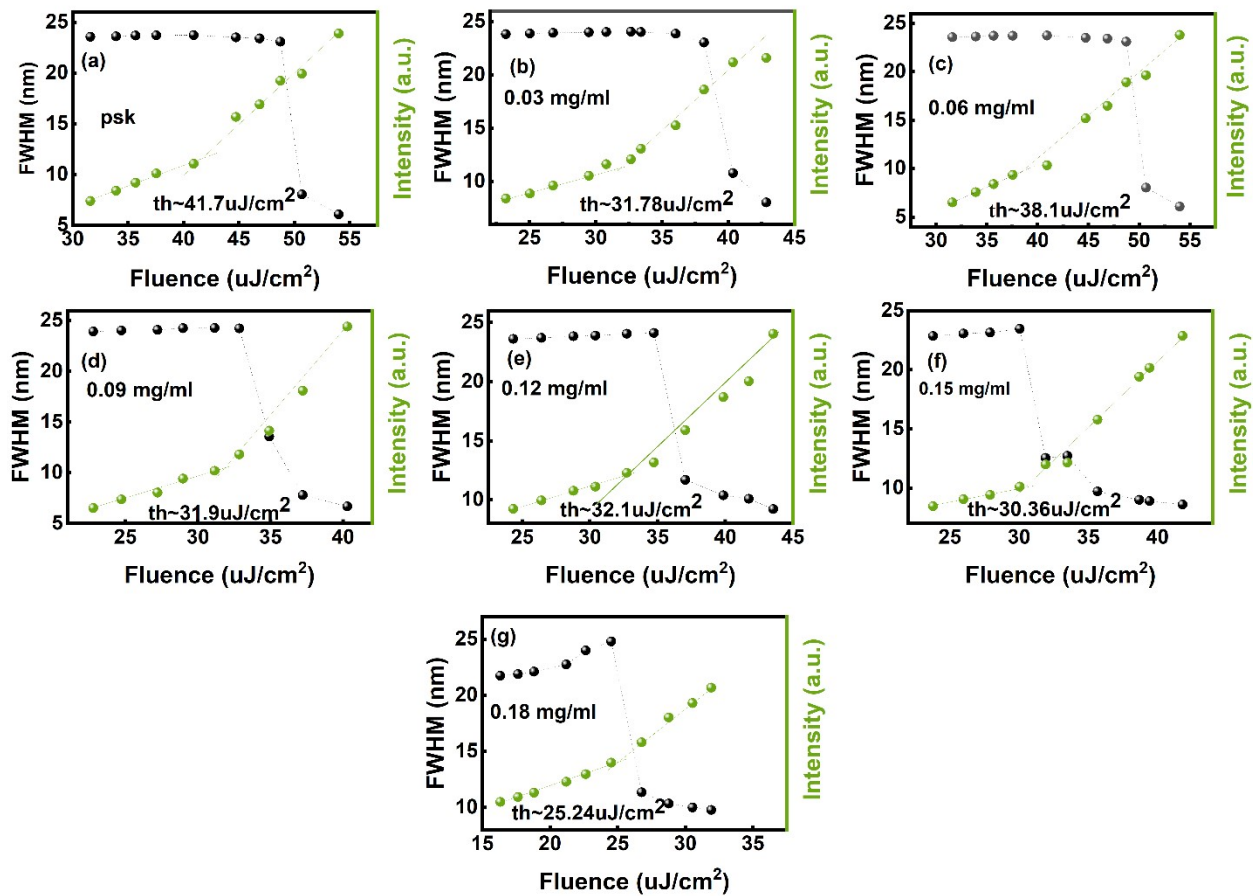


Fig S2. The FWHM and ASE intensity versus excitation fluence of the pure perovskite and different concentrations (0.03-0.18mg/ml GO) of CsPbBr<sub>3</sub>: GO thin film after annealing at 130 °C for 24 hours under nitrogen atmosphere(a-g)

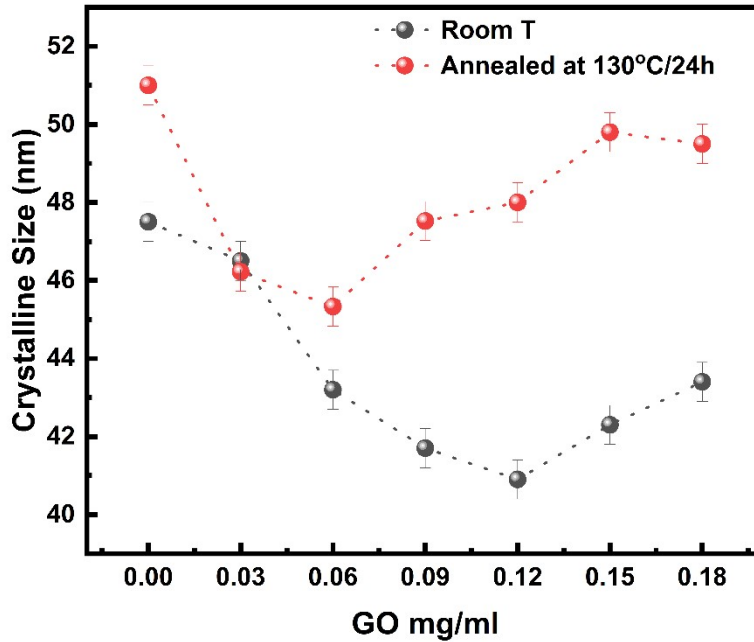


Fig S3. Change in crystal sizes of CsPbBr<sub>3</sub>: GO thin films at 0.03mg/ml, 0.06mg/ml, 0.09mg/ml, 0.12mg/ml, 0.15mg/ml, and 0.18mg/ml GO, respectively.

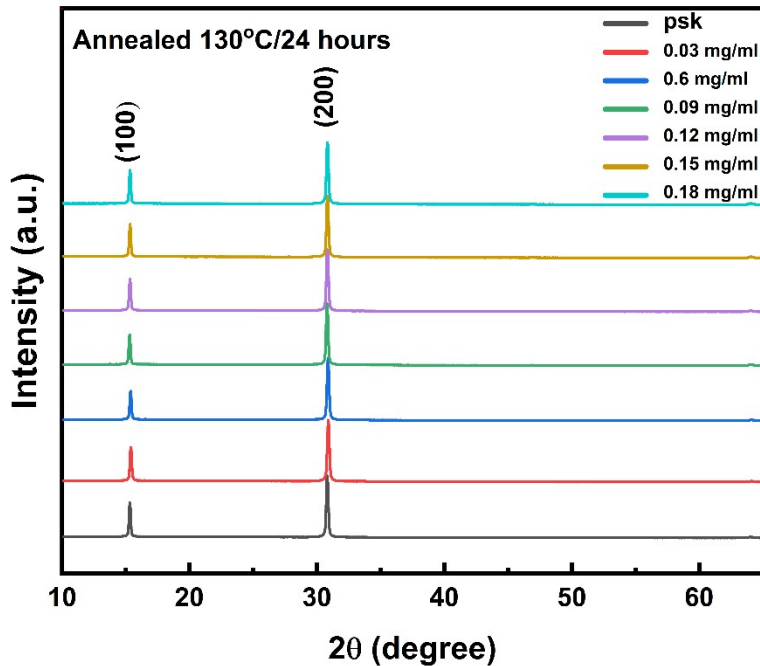


Fig S4. XRD patterns of the parent spectra of the pure CsPbBr<sub>3</sub> thin film and various concentrations of CsPbBr<sub>3</sub>: GO polycrystalline thin films (0.03mg/ml GO-0.18mg/ml) deposited on a glass substrate after annealing at 130 °C for 24 hours.

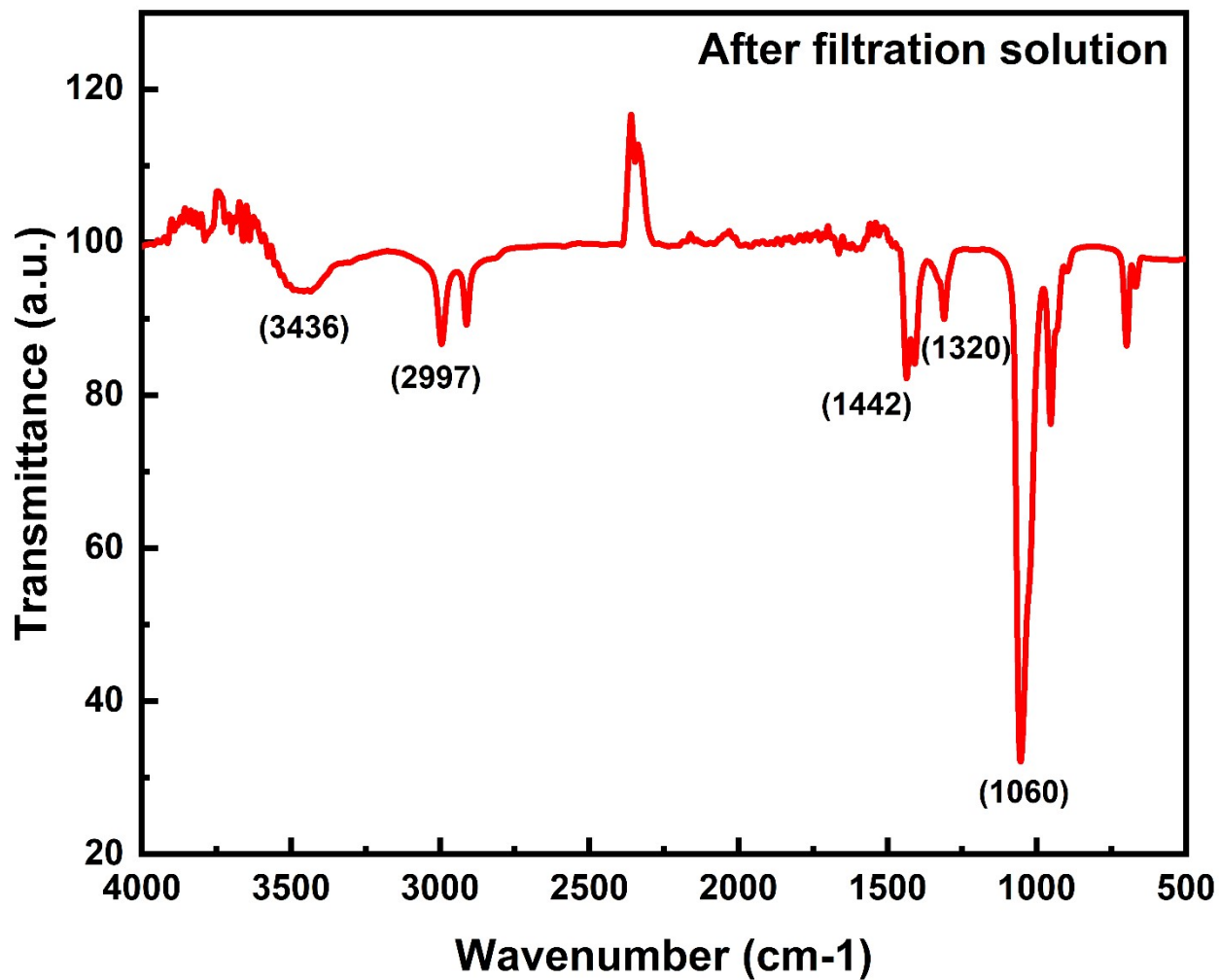


Fig S5. FTIR spectra of PSK: GO 0.18mg/ml solution after filtration.

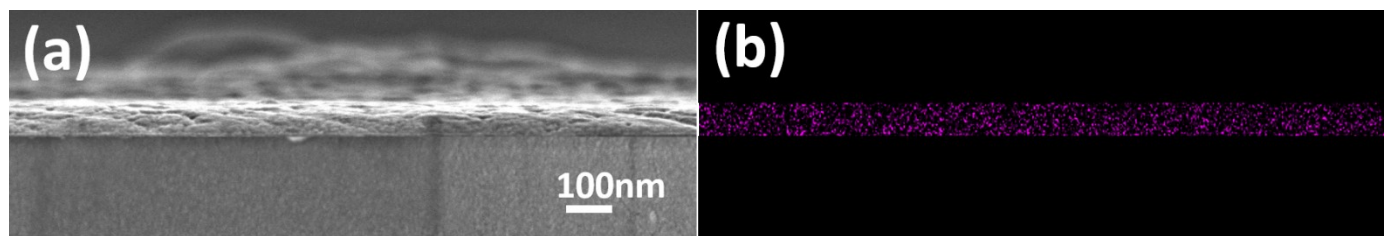


Fig S6. (a)SEM image a side-view and (b) Sulfur EDX elemental mapping of PSK: GO 0.18mg/ml layer intermingled with NH, CH, CH, SH-modified GO nanoparticles.

Table S1. Comparison of FWHM and threshold values of different types of films before and after annealing at 130 °C for 24 hours.

Film Type	FWHM before Ann.	FWHM after Ann.	Threshold before Ann.	Threshold after Ann.
CsPbBr <sub>3</sub>	10.0 nm	11.0 nm	33.9	41.7
CsPbBr <sub>3</sub> +0.03mg/mlGO	9.7 nm	9.29 nm	20.1	31.8
CsPbBr <sub>3</sub> +0.06mg/mlGO	9.0 nm	8.02 nm	19.0	38.1
CsPbBr <sub>3</sub> +0.09mg/mlGO	8.5 nm	8.60 nm	19.1	31.9
CsPbBr <sub>3</sub> +0.12mg/mlGO	7.5 nm	9.21 nm	15	32.1
CsPbBr <sub>3</sub> +0.15mg/mlGO	7.4nm	6.69 nm	14.2	30.4
CsPbBr <sub>3</sub> +0.18mg/mlGO	6.5 nm	6.02 nm	17.2	25.2